


<b>Search Notes</b> 	<b>Application/Control No.</b> 10540486	<b>Applicant(s)/Patent Under Reexamination</b> NISHIKOUJI ET AL.
	<b>Examiner</b> Nguyen, Lauren	<b>Art Unit</b> 2871

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
349	117-120	02/28/2007	LN

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted Primary Examiner Andrew Schechter	02/28/2007	LN

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>